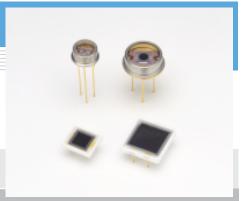
# Si APD **S8664 series**

### Short wavelength type APD



#### **Features**

- High sensitivity at visible range
- Low noise
- High gain
- Low capacitance

#### Applications

- Low-light-level measurement
- Analytical equipment

■ General ratings / Absolute maximum ratings

	Dimensional				Absolute maximum ratings		
Town Nie	outline	Dadwa	Effective *2 active area size	Effective active area	Operating	Storage	
Type No.	/Window	Package	401170 4104 0120	aroa	temperature	temperature	
	material *1				Topr	Tstg	
			(mm)	(mm²)	(°C)	(°C)	
S8664-02K		TO-5	φ0.2	0.03			
S8664-05K	①/ <b>K</b>		φ0.5	0.19		-55 to +100	
S8664-10K	U/K		φ1.0	0.78			
S8664-20K			φ2.0	3.14	-20 to +60		
S8664-30K	@/ <b>K</b>	TO-8	φ3.0	7.0	-20 10 +00		
S8664-50K	@/K		φ5.0	19.6			
S8664-55	3/E	Ceramic	5 × 5	25		-20 to +80	
S8664-1010	4/E	Ceramic	10 × 10	100		-20 10 +00	

■ Electrical and optical characteristics (Typ. Ta=25 °C, unless otherwise noted)

Type No.	Spectral response range $\lambda$	Peak *3 sensitivity wavelength λp	sensitivity S M=1	Quantum efficiency QE M=1 λ=420 nm	Velta VE VE	age BR	Temperature coefficient of VBR	cur	rk * <sup>3</sup> rent	Cut-off frequency fc	Terminal *3 capacitance Ct	Excess *3 Noise index λ=420 nm	Gain M λ=420 nm
					Тур.	Max.		Тур.	Max.				
	(nm)	(nm)	(A/W)	(%)	(V)	(V)	(V/°C)	(nA)	(nA)	(MHz)	(pF)		
S8664-02K								0.1	1	700	0.8		
S8664-05K								0.2	1.5	680	1.6		
S8664-10K								0.3	3	530	4		
S8664-20K	320 to	600	0.24	70	400	500	0.78	0.6	6	280	11	0.2	50
S8664-30K	1000	600	0.24	10	400	500	0.76	1	15	140	22	0.2	50
S8664-50K								3	35	60	55		
S8664-55								5	50	40	80		
S8664-1010								10	100	11	270		

<sup>\*1:</sup> K: Borosilicate glass E: Epoxy resin

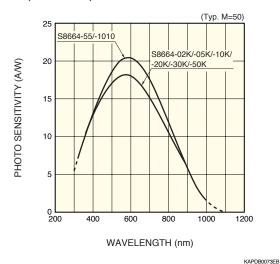


<sup>\*2:</sup> Area in which a typical gain can be obtained.

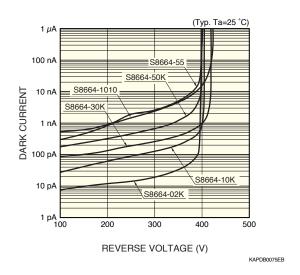
<sup>\*3:</sup> Values measured at a gain listed in the characteristics table.

## SI APD S8664 series

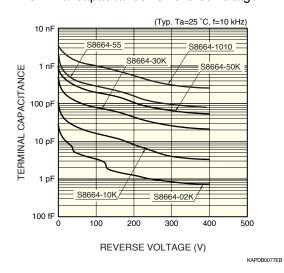
#### ■ Spectral response



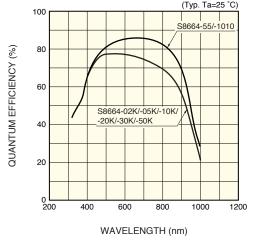
### ■ Dark current vs. reverse voltage



#### ■ Terminal capacitance vs. reverse voltage

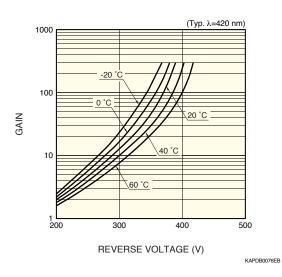


### ■ Quantum efficiency vs. wavelength



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#### ■ Gain vs. reverse voltage

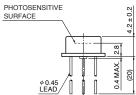


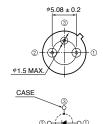
2

#### ■ Dimensional outlines (unit: mm)

#### ① S8664-02K/-05K/-10K/-20K







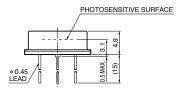
The glass window may extend a maximum of 0.2 mm beyond the upper surface of the cap.

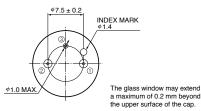
Type No.	а	
S8664-02K	φ0.2	
S8664-05K	φ0.5	
S8664-10K	φ1.0	
S8664-20K	φ2.0	ı

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#### 2 S8664-30K/-50K





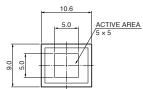


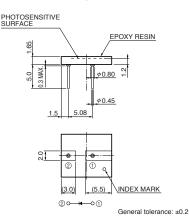


Type No.	а
S8664-30K	φ3.0
S8664-50K	φ5.0

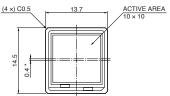
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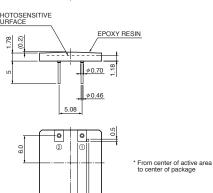
#### 3 S8664-55





4 S8664-1010





0.5

General tolerance: ±0.2

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